 earch Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/773,138	CRIST ET AL.	
Examiner	Art Unit	
 Son M. Tang	2612	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
340	573.3	5/1/2006	TANG
	573.1	1)
J	652, 687		J
42/105; 119/29,720			

SEARCH N (INCLUDING SEAR)		·)
	DATE	EXMR
340/573.1,573.3,652,687 42/105 119/29,720 Text only	5/1/2006	TANG
Daniel Wu	4/28/2006	TANG
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